

Search Notes

Application/Control No.

10/511,605

Examiner

Hwei-Siu C. Payer

Applicant(s)/Patent under
Reexamination

YAMAGUCHI ET AL.

Art Unit

3724

SEARCHED

Class	Subclass	Date	Examiner
030	34.1	8-1-06	Payer
	43.6		
	43.9		
	43.92		
	526		
D28	49		
	51		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR